

UNISONIC TECHNOLOGIES CO., LTD

4NM90 **Preliminary Power MOSFET**

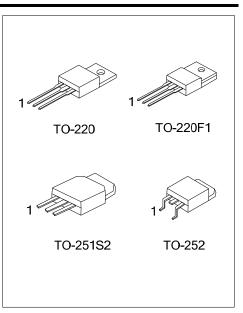
4.0A, 900V N-CHANNEL SUPER-JUNCTION MOSFET

DESCRIPTION

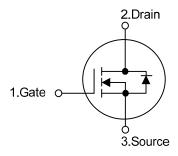
The UTC 4NM90 is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at DC-DC, AC-DC converters for power applications.

FEATURES

- * $R_{DS(ON)}$ < 4.1 Ω @ V_{GS} = 10V, I_D = 2.0A
- * Fast switching capability
- * Avalanche energy tested
- * Improved dv/dt capability, high ruggedness



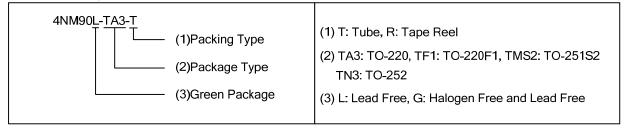
SYMBOL



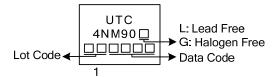
ORDERING INFORMATION

Ordering Number		Daakaga	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
4NM90L-TA3-T	4NM90G-TA3-T	TO-220	20 G D S T		Tube		
4NM90L-TF1-T	4NM90G-TF1-T	TO-220F1	G	D	S	Tube	
4NM90L-TMS2-T	4NM90G-TMS2-T	TO-251S2	G	D	S	Tube	
4NM90L-TN3-R	4NM90G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate S: Source D: Drain



■ MARKING



■ **ABSOLUTE MAXIMUM RATINGS** (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	900	V
Gate-Source Voltage		V_{GSS}	±30	V
Continuous Drain Current	Continuous	I _D	4.0	Α
Pulsed Drain Current	Pulsed (Note 2)	I _{DM}	16	Α
Avalanche Current (Note 2)		I _{AR}	1.2	Α
Single Pulsed Avalanche Energy Single Pulsed (Note		E _{AS}	114	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	1.34	V/ns
	TO-220		110	W
Power Dissipation	TO-220F1	P_D	38	W
	TO-25S2/TO-252		54	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 159mH, I_{AS} = 1.2A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}$ C.
- 4. $I_{SD} \le 4.0 \text{A}$, di/dt $\le 200 \text{A}/\mu\text{s}$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}\text{C}$.

■ THERMAL DATA

PARAMETER		SYMBOL	RATING	UNIT	
Junction to Ambient	TO-220/TO-220F1	0	62.5	°C/W	
	TO-251S2/TO-252	θ _{JA}	110	°C/W	
Junction to Case	TO-220		1.14	°C/W	
	TO-220F1	θις	3.29	°C/W	
	TO-251S2/TO-252		2.3	°C/W	

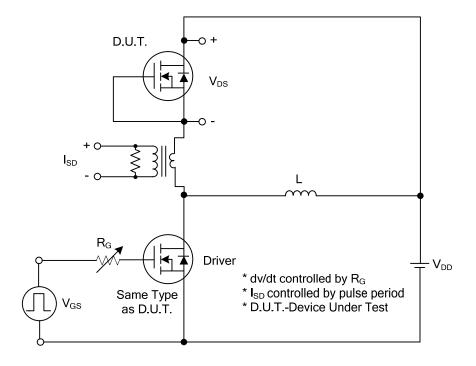
■ **ELECTRICAL CHARACTERISTICS** (T_J =25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV_{DSS}	$V_{GS} = 0V, I_{D} = 250\mu A$	900			٧	
Drain-Source Leakage Current		I _{DSS}	$V_{DS} = 900V, V_{GS} = 0V$			10	μΑ	
Gate-Source Leakage Current	Forward	I_{GSS}	$V_{GS} = 30V, V_{DS} = 0V$			100	nA	
	Reverse	IGSS	$V_{GS} = -30V, V_{DS} = 0V$			-100	nA	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.5		4.5	V	
Static Drain-Source On-State Resistance		R _{DS(ON)}	$V_{GS} = 10V, I_D = 2.0A$			4.1	Ω	
DYNAMIC CHARACTERISTICS	i							
Input Capacitance		C _{ISS}			280		pF	
Output Capacitance		Coss	V_{GS} =0V, V_{DS} =25V, f=1.0MHz		125		pF	
Reverse Transfer Capacitance		C_{RSS}			7		pF	
SWITCHING CHARACTERISTICS								
Total Gate Charge (Note 1)		Q_G	 V _{DS} =50V, I _D =1.3A, I _G =100μA		45		nC	
Gate to Source Charge		Q_{GS}	V _{GS} =10V (Note 1,2)		4		nC	
Gate to Drain Charge		Q_GD	VGS-10V (NOIC 1,2)		8		nC	
Turn-ON Delay Time (Note 1)		$t_{D(ON)}$			42		nS	
Rise Time		t_R	V_{DD} =30V, I_{D} =0.5A, R_{G} =25 Ω ,		55		nS	
Turn-OFF Delay Time		$t_{D(OFF)}$	V _{GS} =10V (Note 1,2)		130		nS	
Fall-Time		t_{F}			35		nS	
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Body-Diode Continuous Current		Is				4	Α	
Maximum Body-Diode Pulsed Current		I _{SM}				16	Α	
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	I _S =4.0A, V _{GS} =0V			1.4	V	
Body Diode Reverse Recovery Time (Note 1)		t _{rr}	I _S =4.0A, V _{GS} =0V,		530		nS	
Body Diode Reverse Recovery Charge		Q_{rr}	dI _F /dt=100A/μs		3.75		μC	

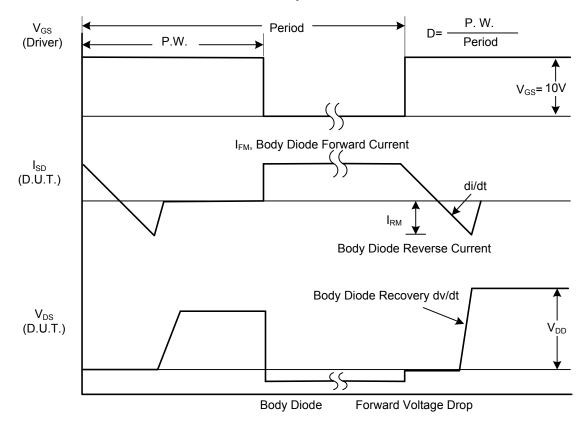
Notes: 1. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2%.

^{2.} Essentially independent of operating ambient temperature.

■ TEST CIRCUITS AND WAVEFORMS

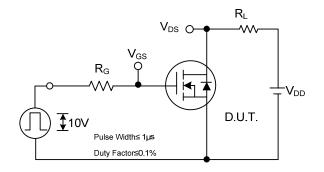


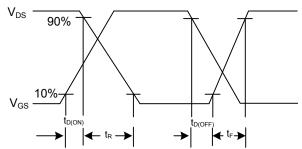
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

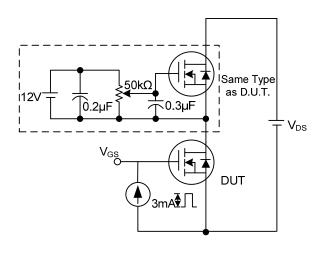
■ TEST CIRCUITS AND WAVEFORMS (Cont.)

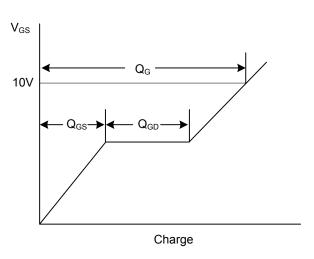




Switching Test Circuit

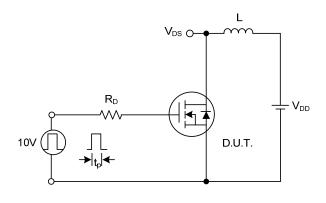
Switching Waveforms

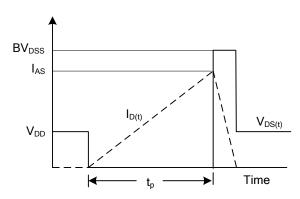




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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